

Notice of References Cited	Application/Control No. 10/606,801	Applicant(s)/Patent Under Reexamination TSUJITA ET AL.	
	Examiner Tianjie Chen	Art Unit 2652	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,338,646	08-1994	Nakayama et al.	430/270.11
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	JP 02046442 A	02-1990	Japan	YOSHIDA et al.	G03C 01/00
	O					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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